## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re U.S. Patent Application of:

INVENTORS: Fletcher et al.

SERIAL NO.: To be assigned

ART UNIT:

FILED: herewith

**EXAMINER:** 

TITLE: PIN Detector Apparatus and Method of Fabrication

ATTORNEY DOCKET NO.: 901.0120.U1(US)

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

## Dear Sir:

Pursuant to Sections 609 and 707.05(b) of the MPEP and 37 CFR 1.97-1.99, copies are herewith submitted of documents which may be pertinent to the invention as claimed in the above-identified application. The attached form PTO-1449 lists these documents.

The citation of these documents should not be construed as a representation that a thorough search has been made, or that other, more pertinent material is not available.

Respectfully submitted,

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## INFORMATION DISCLOSURE CITATION FORM FOR PATENT APPLICATION

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US-US- Applicant(s): Fletcher et al..

Group: N/A

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U.S. PATENT DOCUMENTS Name of Patentee or Applicant Class Sub-class Publication Date Document Number Examiner (MM-DD-YYYY) Initials (Number-Kind Code) 437 003 US-4,782,028 11-01-1988 Farrier et al. 021 437 Chang et al. US-5,137,837 08-11-1992 438 154 09-15-1998 Vu et al. US-5,807,771 443 257 Tyson et al. 06-06-2000 US-6,072,224 09-09-2003 Parab 257 347 US-6,617,646 B2 US-US-US-US-US-US-US-US-US-

FOREIGN PATENT DOCUMENTS Translation? Publication Date (MM-DD-YYYY) Name Of Patentee of Applicant Examiner Document Number Yes/No/n/a (Country Code-Number-Kind Code) Initials

OTHER DOCUMENTS (Author (Capitalize), Title, Date, Pages, Etc., if known) F. FOULON, L.ROUSSEAU, L.BABADJIAN, S.SPIRKOVITCH, A.BRAMBILLA and P.BERGONZO, "A New Technique for the Fabrication of Thin Silicon Radiation Detectors", pgs. 218-220, IEEE Transactions on Nuclear Science, Vol. 46, No. 3, June 1999,

Date Considered: Examiner's Signature:

Initial if reference was considered, whether or not citation is in conformance with MPEP. Mark through citation if not considered. Include a copy of this citation form with your next correspondence to the Applicant(s).